

August 1991

### **Features**

- 12A, 80V and 100V
- $r_{DS(on)} = 0.2\Omega$
- SOA is Power-Dissipation Limited
- Nanosecond Switching Speeds
- Linear Transfer Characteristics
- High Input Impedance
- Majority Carrier Device

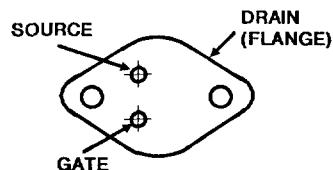
### **Description**

The RFM12N08 and RFM12N10 and the RFP12N08 and RFP12N10 are n-channel enhancement-mode silicon-gate power field-effect transistors designed for applications such as switching regulators, switching converters, motor drivers, relay drivers, and drivers for high-power bipolar switching transistors requiring high speed and low gate-drive power. These types can be operated directly from integrated circuits.

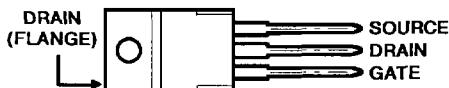
The RFM-series types are supplied in the JEDEC TO-204AA steel package and the RFP-series types in the JEDEC TO-220AB plastic package.

### **Packages**

TO-204AA

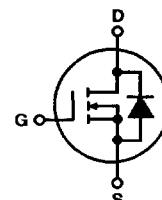


TO-220AB  
TOP VIEW



### **Terminal Diagram**

N-CHANNEL ENHANCEMENT MODE



### **Absolute Maximum Ratings ( $T_C = 25^\circ C$ ), Unless Otherwise Specified**

	RFM12N08	RFM12N10	RFP12N08	RFP12N10	UNITS
Drain-Source Voltage .....	$V_{DSS}$	80	100	80	V
Drain-Gate Voltage ( $R_{GS} = 1m\Omega$ ) .....	$V_{DGR}$	80	100	80	V
Continuous Drain Current					
RMS Continuous .....	$I_D$	12	12	12	A
Pulsed Drain Current .....	$I_{DM}$	30	30	30	A
Gate-Source Voltage .....	$V_{GS}$	$\pm 20$	$\pm 20$	$\pm 20$	V
Maximum Power Dissipation					
$T_C = +25^\circ C$ .....	$P_D$	75	75	60	W
Above $T_C = +25^\circ C$ , Derate Linearly .....		0.6	0.6	0.48	W/ $^\circ C$
Operating and Storage Junction .....	$T_J, T_{STG}$	-55 to +150	-55 to +150	-55 to +150	$^\circ C$
Temperature Range					

4

N-CHANNEL  
POWER MOSFETS

**Specifications RFM12N08, RFM12N10, RFP12N08, RFP12N10**

**ELECTRICAL CHARACTERISTICS, At Case Temperature ( $T_c$ )=25°C unless otherwise specified**

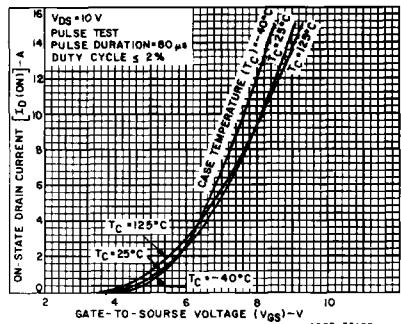
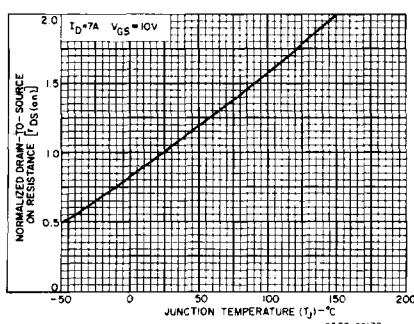
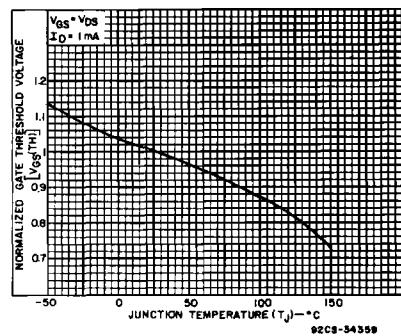
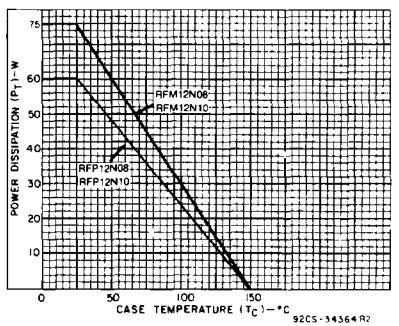
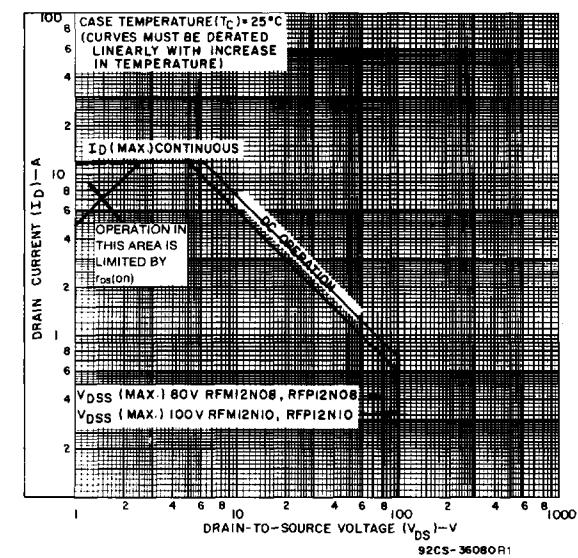
CHARACTERISTIC	SYMBOL	TEST CONDITIONS	LIMITS				UNITS	
			RFM12N08 RFP12N08		RFM12N10 RFP12N10			
			Min.	Max.	Min.	Max.		
Drain-Source Breakdown Voltage	$BV_{DSS}$	$I_D=1\text{ mA}$ $V_{GS}=0$	80	—	100	—	V	
Gate-Threshold Voltage	$V_{GS(\text{th})}$	$V_{GS}=V_{DS}$ $I_D=1\text{ mA}$	2	4	2	4	V	
Zero-Gate Voltage Drain Current	$I_{DS(0)}$	$V_{DS}=65\text{ V}$ $V_{DS}=80\text{ V}$	—	1	—	—	$\mu\text{A}$	
		$T_c=125^\circ\text{C}$ $V_{DS}=65\text{ V}$ $V_{DS}=80\text{ V}$	—	50	—	—		
		—	—	—	—	50		
Gate-Source Leakage Current	$I_{GSS}$	$V_{GS}=\pm 20\text{ V}$ $V_{DS}=0$	—	100	—	100	nA	
Drain-Source On Voltage	$V_{DS(\text{on})}^a$	$I_D=6\text{ A}$ $V_{GS}=10\text{ V}$	—	1.2	—	1.2	V	
		$I_D=12\text{ A}$ $V_{GS}=10\text{ V}$	—	3.3	—	3.3		
Static Drain-Source On Resistance	$r_{DS(\text{on})}^a$	$I_D=6\text{ A}$ $V_{GS}=10\text{ V}$	—	0.2	—	0.2	$\Omega$	
Forward Transconductance	$g_{fs}^a$	$V_{DS}=10\text{ V}$ $I_D=6\text{ A}$	2	—	2	—	mho	
Input Capacitance	$C_{iss}$	$V_{DS}=25\text{ V}$	—	850	—	850	pF	
Output Capacitance	$C_{oss}$	$V_{GS}=0\text{ V}$	—	300	—	300		
Reverse-Transfer Capacitance	$C_{rss}$	$f = 1\text{ MHz}$	—	150	—	150		
Turn-On Delay Time	$t_{d(on)}$	$V_{DD}=50\text{ V}$	45(Typ)	70	45(Typ)	70	ns	
Rise Time	$t_r$	$I_D=6\text{ A}$	250(Typ)	375	250(Typ)	375		
Turn-Off Delay Time	$t_{d(off)}$	$R_{gen}=R_{gs}=50\Omega$	85(Typ)	130	85(Typ)	130		
Fall Time	$t_f$	$V_{GS}=10\text{ V}$	100(Typ)	150	100(Typ)	150		
Thermal Resistance Junction-to-Case	$R_{\theta JC}$	$RFM12N08$ , $RFM12N10$	—	1.67	—	1.67	$^\circ\text{C}/\text{W}$	
		$RFP12N08$ , $RFP12N10$	—	2.083	—	2.083		

<sup>a</sup>Pulsed: Pulse duration=300  $\mu\text{s}$  max., duty cycle=2%.

**SOURCE-DRAIN DIODE RATINGS AND CHARACTERISTICS**

CHARACTERISTIC	SYMBOL	TEST CONDITIONS	LIMITS				UNITS	
			RFM12N08 RFM12N10		RFP12N08 RFP12N10			
			MIN.	MAX.	MIN.	MAX.		
Diode Forward Voltage	$V_{SD}$	$I_{SD}=6\text{ A}$	—	1.4	—	1.4	V	
Reverse Recovery Time	$t_{rr}$	$I_F=4\text{ A}$ $d_I/dt=100\text{ A}/\mu\text{s}$	150(typ)		150(typ)		ns	

\*Pulse Test: Width  $\leq 300\text{ }\mu\text{s}$ , duty cycle  $\leq 2\%$ .



# RFM12N08, RFM12N10, RFP12N08, RFP12N10

